


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577975	<b>Applicant(s)/Patent Under Reexamination</b>  NIVEN ET AL.
	<b>Examiner</b>  VERONICA FAISON GEE	<b>Art Unit</b>  1793

SEARCHED			
Class	Subclass	Date	Examiner
106	31.28, 31.65	12-2008	vfg

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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